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INTERFACE FOR A MEASURING DEVICE

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(58)177/25.13, 25.16

References Cited (56)

U.S. PATENT DOCUMENTS

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(57)CLAIM

The ornamental design for an interface for a measuring device, as shown and described.

DESCRIPTION

A top view of an interface for a measuring device, such as a scale, embodying aspects of the invention.

The present application is directed to the shape and contour of an interface for a measuring device, such as a key pad or display, of the design illustrated in the drawing. Other features of the drawing, specifically, the shape of other portions of the interface for the measuring device, the shape of the remainder of the measuring device and the type of measuring device, are not considered part of the design currently sought to be patented and have accordingly been shown in broken lines.

1 Claim, 1 Drawing Sheet



